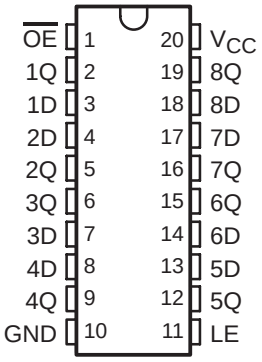
- **Controlled Baseline**
  - **One Assembly/Test Site, One Fabrication Site**
- **Enhanced Diminishing Manufacturing Sources (DMS) Support**
- **Enhanced Product-Change Notification**
- **Qualification Pedigree†**
- **Supports Mixed-Mode Signal Operation (5-V Input and Output Voltages With 3.3-V $V_{CC}$)**
- **Typical $V_{OLP}$ (Output Ground Bounce) <0.8 V at $V_{CC}$ = 3.3 V, $T_A$ = 25°C**
- **Supports Unregulated Battery Operation Down to 2.7 V**
- **$I_{off}$ and Power-Up 3-State Support Hot Insertion**
- **Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors**
- **Latch-Up Performance Exceeds 500 mA Per JESD 17**
- **ESD Protection Exceeds JESD 22**
  - **2000-V Human-Body Model (A114-A)**
  - **200-V Machine Model (A115-A)**

† Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

**PW PACKAGE**
**(TOP VIEW)**




## description/ordering information

This octal latch is designed specifically for low-voltage (3.3-V) $V_{CC}$ operation, but with the capability to provide a TTL interface to a 5-V system environment.

While the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs. When LE is taken low, the Q outputs are latched at the logic levels set up at the D inputs.

A buffered output-enable ($\overline{OE}$) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components.

$\overline{OE}$ does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

When $V_{CC}$ is between 0 and 1.5 V, the devices are in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 1.5 V, $\overline{OE}$ should be tied to $V_{CC}$ through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

Active bus-hold circuitry holds unused or undriven inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

This device is fully specified for hot-insertion applications using $I_{off}$ and power-up 3-state. The $I_{off}$ circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The power-up 3-state circuitry places the outputs in the high-impedance state during power up and power down, which prevents driver conflict.

## ORDERING INFORMATION

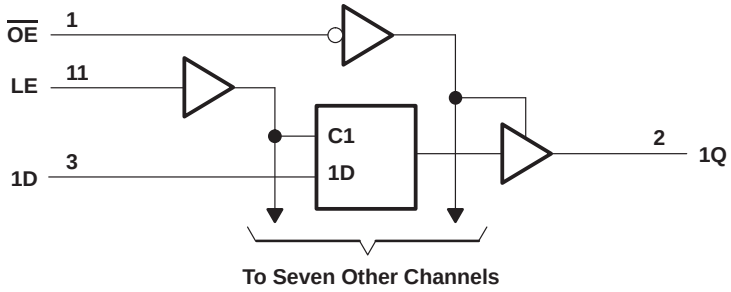
| $T_A$ | PACKAGE† | | ORDERABLE PART NUMBER | TOP-SIDE MARKING |
|---|---|---|---|---|
| −40°C to 85°C | TSSOP − PW | Tape and reel | SN74LVTH373IPWREP | LH373EP |

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

**FUNCTION TABLE**
**(each latch)**

| INPUTS | | | OUTPUT |
|---|---|---|---|
| $\overline{OE}$ | LE | D | Q |
| L | H | H | H |
| L | H | L | L |
| L | L | X | $Q_0$ |
| H | X | X | Z |

## logic diagram (positive logic)



### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, $V_{CC}$ . . . . . −0.5 V to 4.6 V
Input voltage range, $V_I$ (see Note 1) . . . . . −0.5 V to 7 V
Voltage range applied to any output in the high-impedance or power-off state, $V_O$ (see Note 1) . . . . . −0.5 V to 7 V
Voltage range applied to any output in the high state, $V_O$ (see Note 1) . . . . . −0.5 V to $V_{CC}$ + 0.5 V
Current into any output in the low state, $I_O$ . . . . . 128 mA
Current into any output in the high state, $I_O$ (see Note 2) . . . . . 64 mA
Input clamp current, $I_{IK}$ ($V_I$ < 0) . . . . . −50 mA
Output clamp current, $I_{OK}$ ($V_O$ < 0) . . . . . −50 mA
Package thermal impedance, $\theta_{JA}$ (see Note 3) . . . . . 83°C/W
Storage temperature range, $T_{stg}$ . . . . . −65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
2. This current flows only when the output is in the high state and $V_O > V_{CC}$.
3. The package thermal impedance is calculated in accordance with JESD 51-7.

### recommended operating conditions (see Note 4)

| | | | MIN | MAX | UNIT |
|---|---|---|---|---|---|
| $V_{CC}$ | Supply voltage | | 2.7 | 3.6 | V |
| $V_{IH}$ | High-level input voltage | | 2 | | V |
| $V_{IL}$ | Low-level input voltage | | | 0.8 | V |
| $V_I$ | Input voltage | | | 5.5 | V |
| $I_{OH}$ | High-level output current | | | −32 | mA |
| $I_{OL}$ | Low-level output current | | | 64 | mA |
| $\Delta t/\Delta v$ | Input transition rise or fall rate | Outputs enabled | | 10 | ns/V |
| $\Delta t/\Delta V_{CC}$ | Power-up ramp rate | | 200 | | μs/V |
| $T_A$ | Operating free-air temperature | | −40 | 85 | °C |

NOTE 4: All unused control inputs of the device must be held at $V_{CC}$ or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | | MIN | TYP† | MAX | UNIT |
|---|---|---|---|---|---|---|---|
| $V_{IK}$ | | $V_{CC}$ = 2.7 V, | $I_I$ = −18 mA | | | −1.2 | V |
| $V_{OH}$ | | $V_{CC}$ = 2.7 V to 3.6 V, | $I_{OH}$ = −100 μA | $V_{CC}$−0.2 | | | V |
| | | $V_{CC}$ = 2.7 V, | $I_{OH}$ = −8 mA | 2.4 | | | |
| | | $V_{CC}$ = 3 V | $I_{OH}$ = −32 mA | 2 | | | |
| $V_{OL}$ | | $V_{CC}$ = 2.7 V | $I_{OL}$ = 100 μA | | | 0.2 | V |
| | | | $I_{OL}$ = 24 mA | | | 0.5 | |
| | | $V_{CC}$ = 3 V | $I_{OL}$ = 16 mA | | | 0.4 | |
| | | | $I_{OL}$ = 32 mA | | | 0.5 | |
| | | | $I_{OL}$ = 64 mA | | | 0.55 | |
| $I_I$ | | $V_{CC}$ = 0 or 3.6 V, | $V_I$ = 5.5 V | | | 10 | μA |
| | Control inputs | $V_{CC}$ = 3.6 V, | $V_I$ = $V_{CC}$ or GND | | | ±1 | |
| | Data inputs | $V_{CC}$ = 3.6 V | $V_I$ = $V_{CC}$ | | | 1 | |
| | | | $V_I$ = 0 | | | −5 | |
| $I_{off}$ | | $V_{CC}$ = 0, | $V_I$ or $V_O$ = 0 to 4.5 V | | | ±100 | μA |
| $I_{I(hold)}$ | Data inputs | $V_{CC}$ = 3 V | $V_I$ = 0.8 V | 75 | | | μA |
| | | | $V_I$ = 2 V | −75 | | | |
| | | $V_{CC}$ = 3.6 V‡, | $V_I$ = 0 to 3.6 V | | | 500<br>−750 | |
| $I_{OZH}$ | | $V_{CC}$ = 3.6 V, | $V_O$ = 3 V | | | 5 | μA |
| $I_{OZL}$ | | $V_{CC}$ = 3.6 V, | $V_O$ = 0.5 V | | | −5 | μA |
| $I_{OZPU}$ | | $V_{CC}$ = 0 to 1.5 V, $V_O$ = 0.5 V to 3 V, $\overline{OE}$ = don't care | | | | ±100 | μA |
| $I_{OZPD}$ | | $V_{CC}$ = 1.5 V to 0, $V_O$ = 0.5 V to 3 V, $\overline{OE}$ = don't care | | | | ±100 | μA |
| $I_{CC}$ | | $V_{CC}$ = 3.6 V, $I_O$ = 0, $V_I$ = $V_{CC}$ or GND | Outputs high | | | 0.19 | mA |
| | | | Outputs low | | | 5 | |
| | | | Outputs disabled | | | 0.19 | |
| $\Delta I_{CC}$§ | | $V_{CC}$ = 3 V to 3.6 V, One input at $V_{CC}$ − 0.6 V, Other inputs at $V_{CC}$ or GND | | | | 0.2 | mA |
| $C_i$ | | $V_I$ = 3 V or 0 | | | 3 | | pF |
| $C_o$ | | $V_O$ = 3 V or 0 | | | 7 | | pF |

† All typical values are at $V_{CC}$ = 3.3 V, $T_A$ = 25°C.
‡ This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to another.
§ This is the increase in supply current for each input that is at the specified TTL voltage level, rather than $V_{CC}$ or GND.

## timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

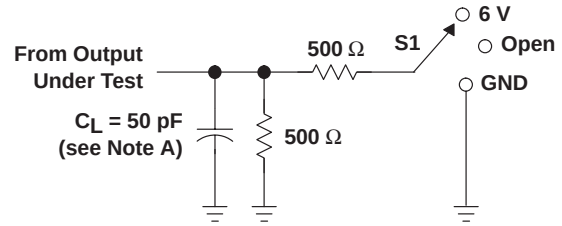
| | | $V_{CC}$ = 3.3 V ± 0.3 V | | $V_{CC}$ = 2.7 V | | UNIT |
|---|---|---|---|---|---|---|
| | | MIN | MAX | MIN | MAX | |
| $t_w$ | Pulse duration, LE high | 3 | | 3 | | ns |
| $t_{su}$ | Setup time, data before LE↓ | 1.1 | | 0.4 | | ns |
| $t_h$ | Hold time, data after LE↓ | 1.4 | | 1.4 | | ns |

**switching characteristics over recommended free-air temperature, $C_L$ = 50 pF (unless otherwise noted) (see Figure 1)**

| PARAMETER | FROM (INPUT) | TO (OUTPUT) | $V_{CC}$ = 3.3 V ± 0.3 V | | | $V_{CC}$ = 2.7 V | | UNIT |
|---|---|---|---|---|---|---|---|---|
| | | | MIN | TYP† | MAX | MIN | MAX | |
| $t_{PLH}$ | D | Q | 1.5 | 2.6 | 3.9 | | 4.5 | ns |
| $t_{PHL}$ | | | 1.5 | 2.6 | 3.9 | | 4.5 | |
| $t_{PLH}$ | LE | Q | 1.7 | 2.7 | 4.2 | | 4.9 | ns |
| $t_{PHL}$ | | | 1.7 | 2.7 | 4.2 | | 4.9 | |
| $t_{PZH}$ | $\overline{OE}$ | Q | 1.3 | 3 | 4.8 | | 5.9 | ns |
| $t_{PZL}$ | | | 1.3 | 3 | 4.8 | | 5.5 | |
| $t_{PHZ}$ | $\overline{OE}$ | Q | 1.9 | 3 | 4.6 | | 4.9 | ns |
| $t_{PLZ}$ | | | 1.9 | 3 | 4.5 | | 4.6 | |

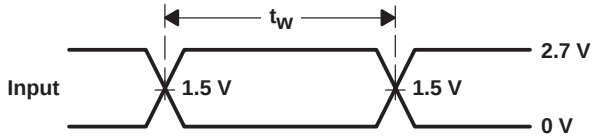
† All typical values are at $V_{CC}$ = 3.3 V, $T_A$ = 25°C.

## PARAMETER MEASUREMENT INFORMATION

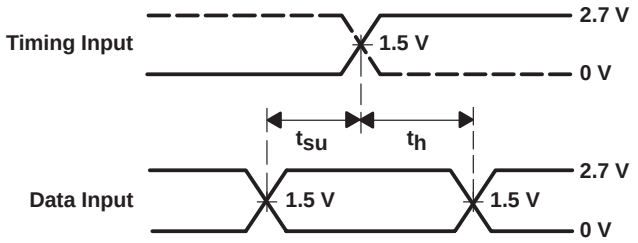



LOAD CIRCUIT

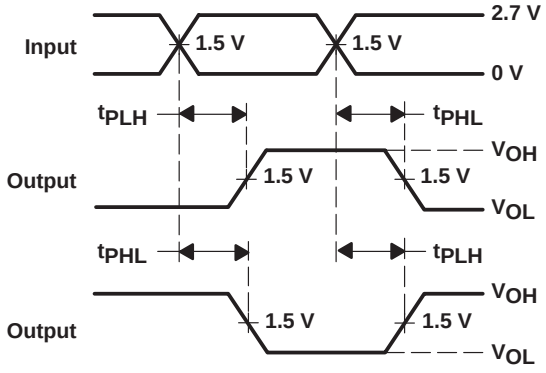
| TEST | S1 |
|---|---|
| $t_{PLH}/t_{PHL}$ | Open |
| $t_{PLZ}/t_{PZL}$ | 6 V |
| $t_{PHZ}/t_{PZH}$ | GND |



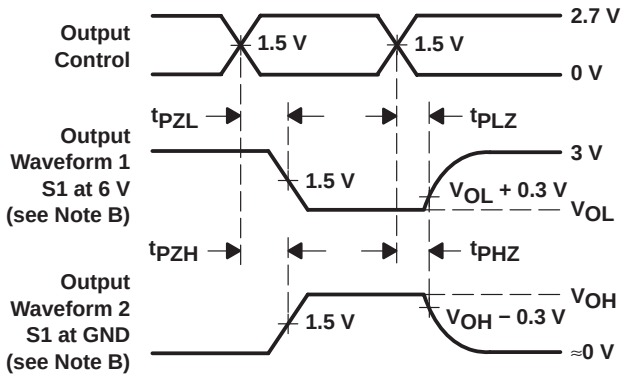

VOLTAGE WAVEFORMS
PULSE DURATION




VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES




VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES
INVERTING AND NONINVERTING OUTPUTS




VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES
LOW- AND HIGH-LEVEL ENABLING

NOTES: A. $C_L$ includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, $Z_O$ = 50 Ω, $t_r$ ≤ 2.5 ns, $t_f$ ≤ 2.5 ns.
D. The outputs are measured one at a time with one transition per measurement.

**Figure 1. Load Circuit and Voltage Waveforms**

## PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material (6) | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|---|---|---|---|---|---|---|---|---|---|---|---|
| SN74LVTH373IPWREP | ACTIVE | TSSOP | PW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | LH373EP | Samples |
| V62/04675-01XE | ACTIVE | TSSOP | PW | 20 | 2000 | RoHS & Green | NIPDAU | Level-1-260C-UNLIM | -40 to 85 | LH373EP | Samples |

(1) The marketing status values are defined as follows:
**ACTIVE:** Product device recommended for new designs.
**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.
**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

**OTHER QUALIFIED VERSIONS OF SN74LVTH373-EP :**

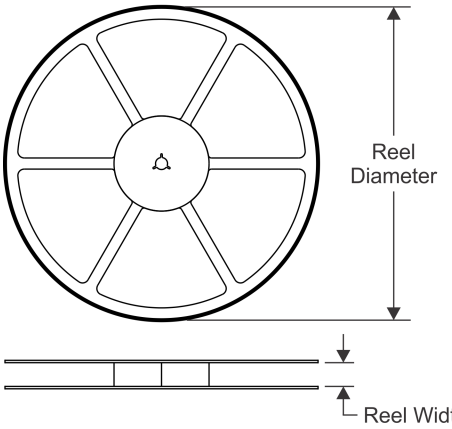
- Catalog: SN74LVTH373
- Military: SN54LVTH373

NOTE: Qualified Version Definitions:

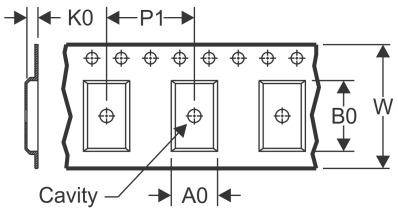
- Catalog - TI's standard catalog product
- Military - QML certified for Military and Defense Applications

## TAPE AND REEL INFORMATION

**REEL DIMENSIONS**

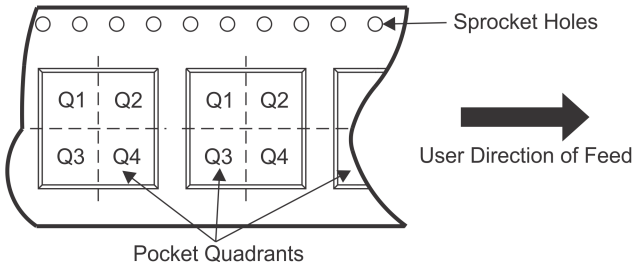



**TAPE DIMENSIONS**




| | |
|---|---|
| A0 | Dimension designed to accommodate the component width |
| B0 | Dimension designed to accommodate the component length |
| K0 | Dimension designed to accommodate the component thickness |
| W | Overall width of the carrier tape |
| P1 | Pitch between successive cavity centers |

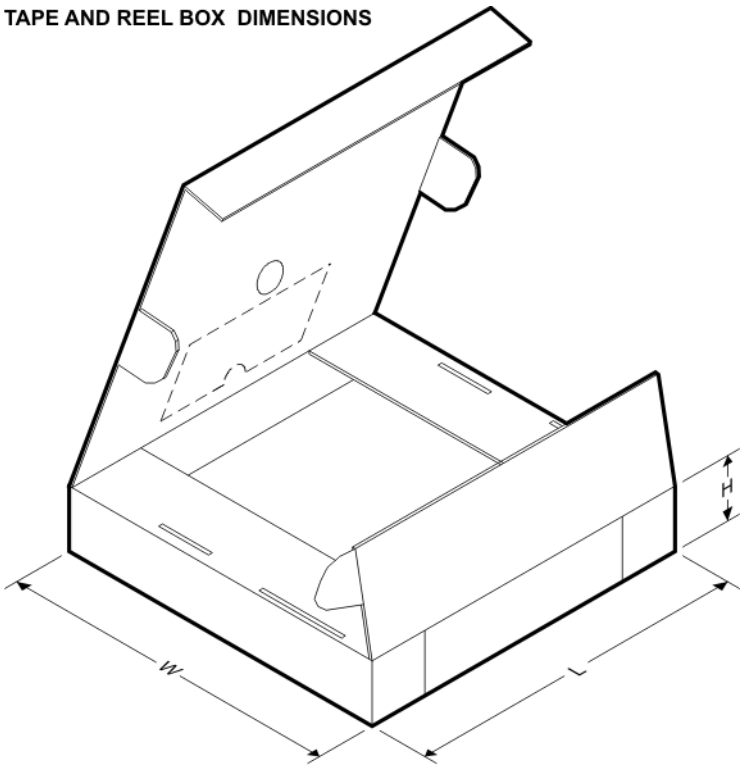
**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**




*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---|---|---|---|---|---|---|---|---|---|---|---|---|
| SN74LVTH373IPWREP | TSSOP | PW | 20 | 2000 | 330.0 | 16.4 | 6.95 | 7.1 | 1.6 | 8.0 | 16.0 | Q1 |

TAPE AND REEL BOX DIMENSIONS




*All dimensions are nominal

| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
|---|---|---|---|---|---|---|---|
| SN74LVTH373IPWREP | TSSOP | PW | 20 | 2000 | 853.0 | 449.0 | 35.0 |

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